

## **XAS study of murataite-based ceramics and crystalline film of ThO<sub>2</sub>**

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### **Sample preparation**

Crystalline film ThO<sub>2</sub> sample was mounted under the synchrotron radiation beam, murataite ceramics sample was mixed with cellulose, ground and pressed into a pellet.

### **EXAFS spectroscopy**

X-ray absorption spectra of the L<sub>III</sub> absorption edge in the X-ray fluorescence yield registration mode (ThO<sub>2</sub> film) and in transmission mode (murataite ceramics) were measured at the station «Structural material science» of the Kurchatov Synchrotron Radiation Center of the National Research Center «Kurchatov Institute» [S1].

Synchrotron radiation was obtained using the 2.5 GeV electron beam at 80-100 mA. Intensity of the incident radiation was registered using ionization chamber filled with nitrogen. A silicon diode with avalanche amplification by FMB Oxford (UK) located at 90° to the beam was used as a fluorescence detector. Ionization chambers filled with argon were used as transmission detectors. The beam size on the sample was 1 mm<sup>2</sup>. A silicon monoblock crystal with a slot forming two reflecting (220) surfaces was used as a monochromator.

Calibration of the X-ray absorption spectra of ThO<sub>2</sub> film and thorium-containing murataite ceramics was done taking into account the Th 4f<sub>7/2</sub> and Th 2p<sub>3/2</sub> binding energies of metallic thorium being 335.2 eV and 16300.3 eV [S2], respectively and the Th 4f<sub>7/2</sub> binding energies in the film and ceramics being 334.4 eV and 334.0 eV, respectively measured earlier by XPS [S3, S4]. With these data in mind, the absorption edges E<sub>0</sub> 16299.5 eV and 16299.1 eV in the spectra of ThO<sub>2</sub> and ceramics, respectively were chosen.

Since the composition and the structure of the first coordination sphere of thorium in ceramics and ThO<sub>2</sub> film were suggested to be the same, the spectra were processed using the Athena program [S5] in the same sequence: background subtraction; calibration by the Th L<sub>III</sub>-edge shift; atomic absorption separation  $\mu_0$ ; Fourier transform with the weight coefficient k<sup>3</sup> in the range k=2÷10 Å<sup>-1</sup>. The threshold energy was chosen by the first derivative of the L<sub>III</sub> absorption edge, afterward, the ionization E<sub>0</sub> threshold energy was varied.

The normalized function  $\chi(k)$  was calculated by (1):

$$\chi(k) = \frac{\mu(k) - \mu_0(k)}{\mu_0(k)}, \quad (1)$$

where  $\mu(k)$  is the experimentally measured absorption coefficient,  $\mu_0(k)$  – absorption coefficient of a free atom modelled by a set of cubic splines,  $k$  – photoelectron wave number.

The number of independent parameters ( $N_{\text{ind}}$ ) was calculated by (2):

$$N_{\text{ind}} = 2\Delta k \Delta r / \pi, \quad (2)$$

where  $\Delta k$  and  $\Delta r$  reflect the number of independent points in the  $k$  and  $R$  spaces, respectively. The value of the amplitude reduction factor  $S_0^2 = 0,9$  was fixed.

The modeling was done by the functional minimization (3):

$$\chi^2_v = \frac{N_{\text{ind}}}{v N_{\text{pts}}} \sum_{i=1}^{N_{\text{pts}}} \frac{(\chi_{\text{data}}(R_i) - \chi_{\text{th}}(R_i))^2}{\varepsilon_i^2} \quad (3),$$

where  $N_{\text{pts}}$  is the number of points in the fitted range,  $v$  is the number of degrees of freedom,  $\chi_{\text{data}}(r_i)$  and  $\chi_{\text{th}}(r_i)$  are the calculated and experimental EXAFS-response respectively,  $\varepsilon_i$  is the measurement uncertainty associated with point  $i$ .

The modeling quality was determined by the R-factor ( $R_f$ ) (absolute standard deviation between the model and experimental spectra). The R-factor ( $R_f$ ) was calculated by (4):

$$R_f = \sum_{i=1}^{N_{\text{pts}}} \frac{[Re(\chi_{\text{data}}(R_i) - \chi_{\text{th}}(R_i))]^2 + [Im(\chi_{\text{data}}(R_i) - \chi_{\text{th}}(R_i))]^2}{[Re(\chi_{\text{data}}(R_i))]^2 + [Im(\chi_{\text{data}}(R_i))]^2}, \quad (4)$$

where  $N_{\text{pts}}$  is the number of points in the modeling range,  $\chi_{\text{th}}(R_i)$  and  $\chi_{\text{data}}(R_i)$  are the calculated and experimental EXAFS signal, respectively. It has to be noted that  $R_f$  is the lower, the higher modeling reliability is.

Spectra modeling was done in the R-space using Artemis program [S5].

## References

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